

MOSFET

OptiMOS™ 8 Power-MOSFET, 80 V

Features

- Dual-side cooled package with lowest junction-top thermal resistance
- N-channel, normal level
- Optimized for motor drives, synchronous rectification and battery protection
- Soft recovery body diode
- 100% avalanche tested
- Superior thermal resistance
- 175°C rated
- Pb-free lead plating; RoHS compliant
- Halogen-free according to IEC61249-2-21
- MSL 1 classified according to JSTD020

Product validation

Qualified according to relevant JEDEC tests.

Table 1 Key performance parameters

| Parameter | Value | Unit |
|---------------------|-------|------|
| V_{DS} | 80 | V |
| $R_{DS(on),max}$ | 1.64 | mΩ |
| I_D | 269 | A |
| Q_{oss} | 147 | nC |
| Q_G (0 V..10 V) | 76 | nC |
| Q_{rr} (100 A/μs) | 162 | nC |

| Part number | Package | Marking | Related links |
|----------------|-----------|----------|---------------|
| ISC016N08NM8SC | PG-WSON-8 | 016N08SC | - |

PG-WSON-8

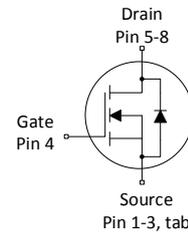
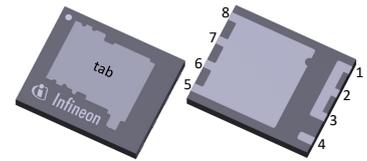




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1 Maximum ratings

at $T_A=25\text{ °C}$, unless otherwise specified

Table 2 Maximum ratings

| Parameter | Symbol | Values | | | Unit | Note / Test condition |
|--|----------------|--------|------|------|------|--|
| | | Min. | Typ. | Max. | | |
| Continuous drain current ¹⁾ | I_D | - | - | 269 | A | $V_{GS}=10\text{ V}, T_C=25\text{ °C}$ |
| | | | | 190 | | $V_{GS}=10\text{ V}, T_C=100\text{ °C}$ |
| | | | | 196 | | $V_{GS}=15\text{ V}, T_C=100\text{ °C}$ |
| | | | | 29 | | $V_{GS}=10\text{ V}, T_A=25\text{ °C}, R_{THJA}=50\text{ °C/W}^2)$ |
| Pulsed drain current ³⁾ | $I_{D,pulse}$ | - | - | 1076 | A | $T_C=25\text{ °C}$ |
| Avalanche energy, single pulse ⁴⁾ | E_{AS} | - | - | 442 | mJ | $I_D=50\text{ A}, R_{GS}=25\text{ }\Omega$ |
| Gate source voltage | V_{GS} | -20 | - | 20 | V | - |
| Power dissipation | P_{tot} | - | - | 263 | W | $T_C=25\text{ °C}$ |
| | | | | 3.0 | | $T_A=25\text{ °C}, R_{THJA}=50\text{ °C/W}^2)$ |
| Operating and storage temperature | T_j, T_{stg} | -55 | - | 175 | °C | IEC climatic category; DIN IEC 68-1: 55/175/56 |

¹⁾ Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature as specified. For other case temperatures please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.

²⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

³⁾ See Diagram 3 for more detailed information.

⁴⁾ See Diagram 13 for more detailed information.

2 Thermal characteristics

Table 3 Thermal characteristics

| Parameter | Symbol | Values | | | Unit | Note / Test condition |
|--|------------|--------|------|------|------|-----------------------|
| | | Min. | Typ. | Max. | | |
| Thermal resistance, junction - case, bottom | R_{thJC} | - | 0.38 | 0.57 | °C/W | - |
| Thermal resistance, junction - case, top | R_{thJC} | | 0.36 | 0.72 | | |
| Thermal resistance, junction - ambient, 6 cm ² cooling area ⁵⁾ | R_{thJA} | | - | 50 | | |

⁵⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

3 Electrical characteristics

at $T_j=25\text{ °C}$, unless otherwise specified

Table 4 Static characteristics

| Parameter | Symbol | Values | | | Unit | Note / Test condition |
|---|---------------|--------|------|------|---------------|--|
| | | Min. | Typ. | Max. | | |
| Drain-source breakdown voltage | $V_{(BR)DSS}$ | 80 | - | - | V | $V_{GS}=0\text{ V}$, $I_D=1\text{ mA}$ |
| Gate threshold voltage | $V_{GS(th)}$ | 2.5 | 3.0 | 3.5 | V | $V_{DS}=V_{GS}$, $I_D=111\text{ }\mu\text{A}$ |
| Zero gate voltage drain current | I_{DSS} | - | 0.1 | 1 | μA | $V_{DS}=80\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=25\text{ °C}$ |
| Zero gate voltage drain current ⁶⁾ | I_{DSS} | - | 10 | 100 | μA | $V_{DS}=80\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=125\text{ °C}$ |
| Gate-source leakage current | I_{GSS} | - | 10 | 100 | nA | $V_{GS}=20\text{ V}$, $V_{DS}=0\text{ V}$ |
| Drain-source on-state resistance | $R_{DS(on)}$ | - | 1.31 | 1.54 | m Ω | $V_{GS}=15\text{ V}$, $I_D=50\text{ A}$ |
| | | | 1.44 | 1.64 | | $V_{GS}=10\text{ V}$, $I_D=50\text{ A}$ |
| | | | 1.61 | 1.87 | | $V_{GS}=8\text{ V}$, $I_D=25\text{ A}$ |
| Gate resistance | R_G | - | 0.95 | - | Ω | - |
| Transconductance ⁶⁾ | g_{fs} | 55 | 110 | - | S | $ V_{DS} \geq 2 I_D R_{DS(on)max}$, $I_D=50\text{ A}$ |

⁶⁾ Defined by design. Not subject to production test.

Table 5 Dynamic characteristics

| Parameter | Symbol | Values | | | Unit | Note / Test condition |
|--|--------------|--------|------|------|------|--|
| | | Min. | Typ. | Max. | | |
| Input capacitance ⁷⁾ | C_{iss} | - | 5500 | 7200 | pF | $V_{GS}=0\text{ V}$, $V_{DS}=40\text{ V}$, $f=1\text{ MHz}$ |
| Output capacitance ⁷⁾ | C_{oss} | | 2230 | 2900 | | |
| Reverse transfer capacitance ⁷⁾ | C_{rss} | | 24 | 42 | | |
| Turn-on delay time | $t_{d(on)}$ | - | 14 | - | ns | $V_{DD}=40\text{ V}$, $V_{GS}=10\text{ V}$, $I_D=50\text{ A}$, $R_{G,ext}=1.6\text{ }\Omega$ |
| Rise time | t_r | | 6.1 | | | |
| Turn-off delay time | $t_{d(off)}$ | | 28 | | | |
| Fall time | t_f | | 7.2 | | | |

⁷⁾ Defined by design. Not subject to production test.

Table 6 Gate charge characteristics ⁸⁾

| Parameter | Symbol | Values | | | Unit | Note / Test condition |
|------------------------------------|---------------|--------|------|------|------|---|
| | | Min. | Typ. | Max. | | |
| Gate to source charge | Q_{gs} | - | 29 | - | nC | $V_{DD}=40\text{ V}$, $I_D=50\text{ A}$, $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate charge at threshold | $Q_{g(th)}$ | - | 17 | - | nC | |
| Gate to drain charge ⁹⁾ | Q_{gd} | - | 15 | 19 | nC | |
| Switching charge | Q_{sw} | - | 27 | - | nC | |
| Gate charge total ⁹⁾ | Q_g | - | 76 | 99 | nC | |
| Gate plateau voltage | $V_{plateau}$ | - | 5.3 | - | V | |
| Gate charge total, sync. FET | $Q_{g(sync)}$ | - | 69 | - | nC | $V_{DS}=0.1\text{ V}$, $V_{GS}=0\text{ to }10\text{ V}$ |
| Output charge ⁹⁾ | Q_{oss} | - | 147 | 191 | nC | $V_{DS}=40\text{ V}$, $V_{GS}=0\text{ V}$ |

⁸⁾ See figure 16 for gate charge parameter definition.

⁹⁾ Defined by design. Not subject to production test.

Table 7 Reverse diode

| Parameter | Symbol | Values | | | Unit | Note / Test condition |
|--|---------------|--------|------|------|------|--|
| | | Min. | Typ. | Max. | | |
| Diode continuous forward current | I_S | - | - | 232 | A | $T_C=25\text{ °C}$ |
| Diode pulse current | $I_{S,pulse}$ | - | - | 1076 | | |
| Diode forward voltage | V_{SD} | - | 0.84 | 1.0 | V | $V_{GS}=0\text{ V}$, $I_F=50\text{ A}$, $T_j=25\text{ °C}$ |
| Reverse recovery time ¹⁰⁾ | t_{rr} | - | 187 | 374 | ns | $V_R=40\text{ V}$, $I_F=50\text{ A}$, $di_F/dt=100\text{ A}/\mu\text{s}$ |
| Reverse recovery charge ¹⁰⁾ | Q_{rr} | - | 162 | 325 | nC | |
| Reverse recovery time ¹⁰⁾ | t_{rr} | - | 39 | 78 | ns | $V_R=40\text{ V}$, $I_F=50\text{ A}$, $di_F/dt=500\text{ A}/\mu\text{s}$ |
| Reverse recovery charge ¹⁰⁾ | Q_{rr} | - | 209 | 418 | nC | |

¹⁰⁾ Defined by design. Not subject to production test.

4 Electrical characteristics diagrams

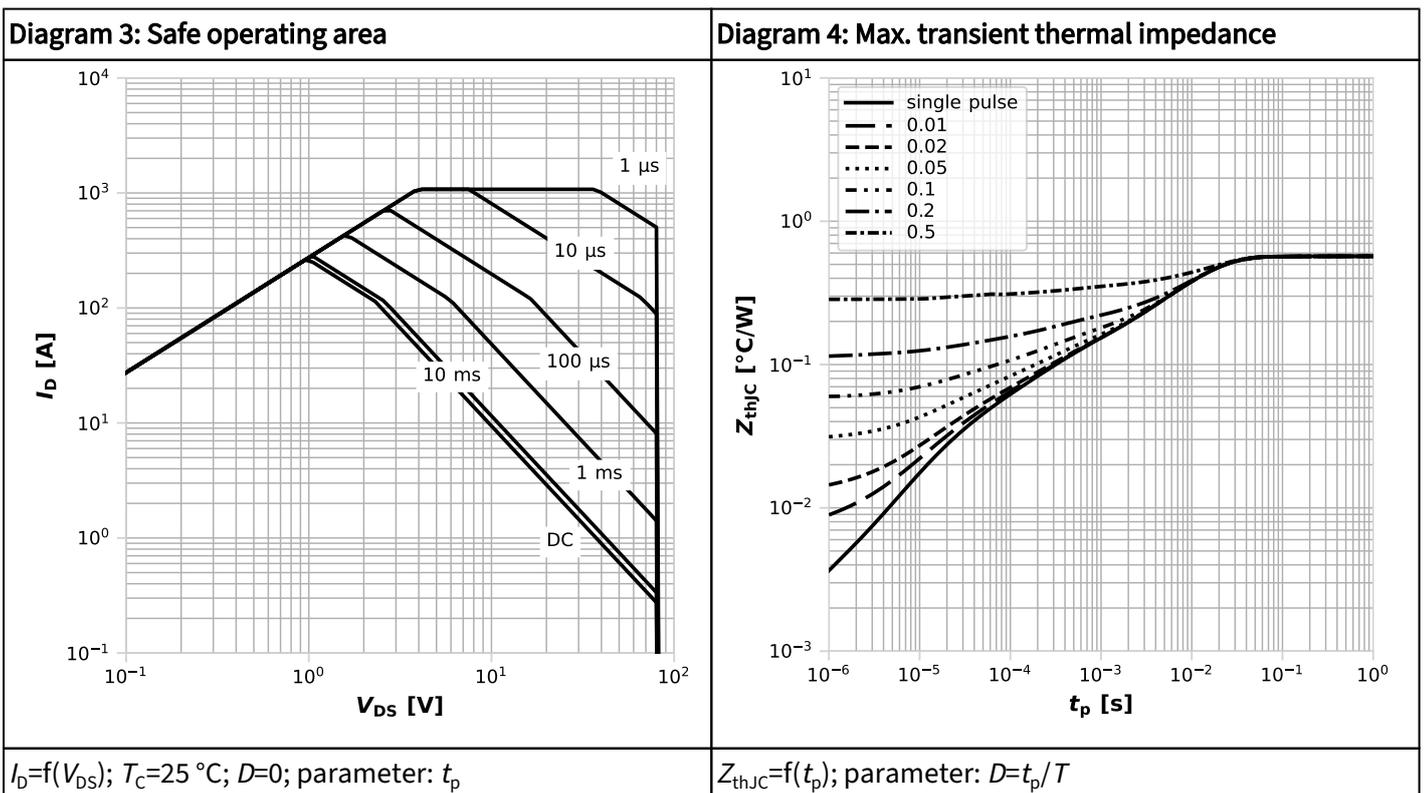
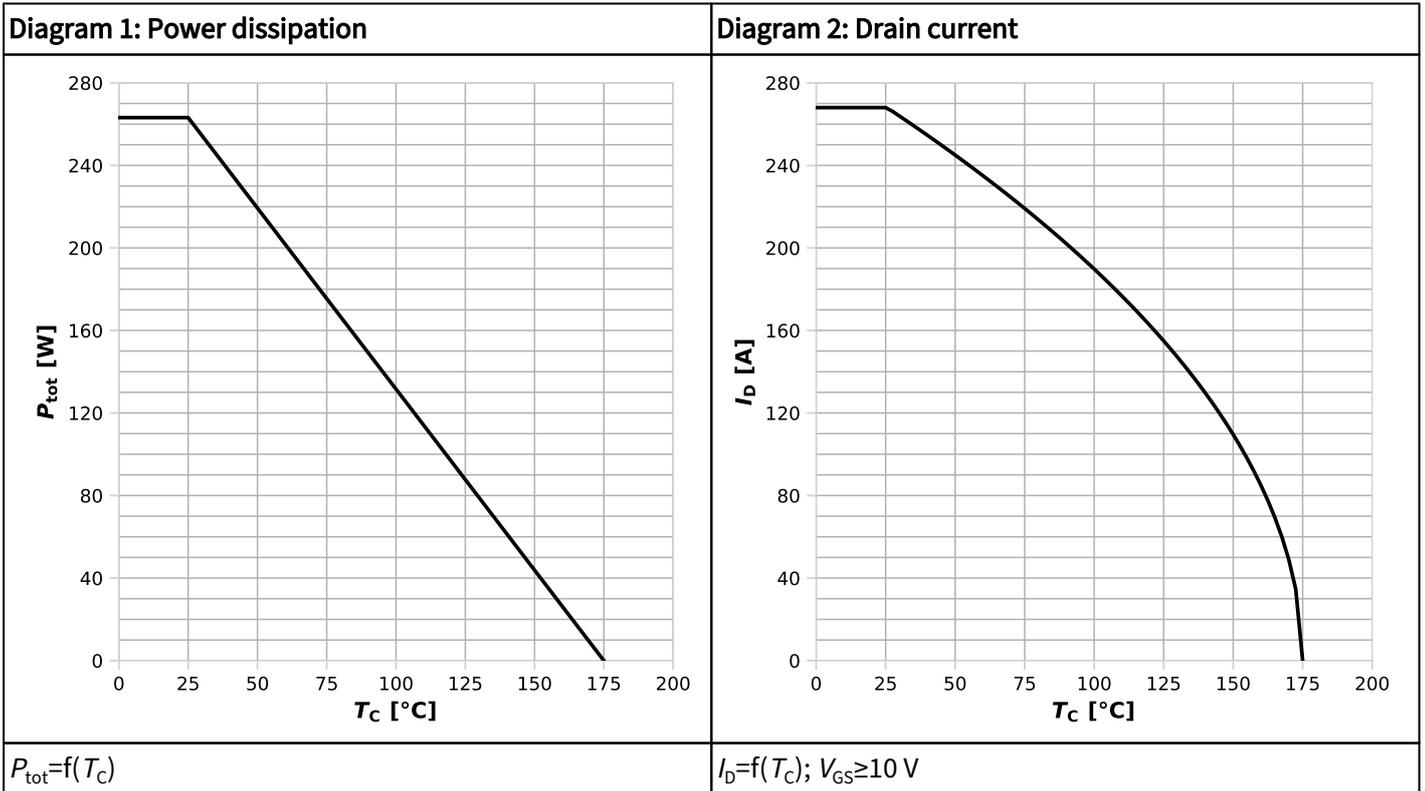
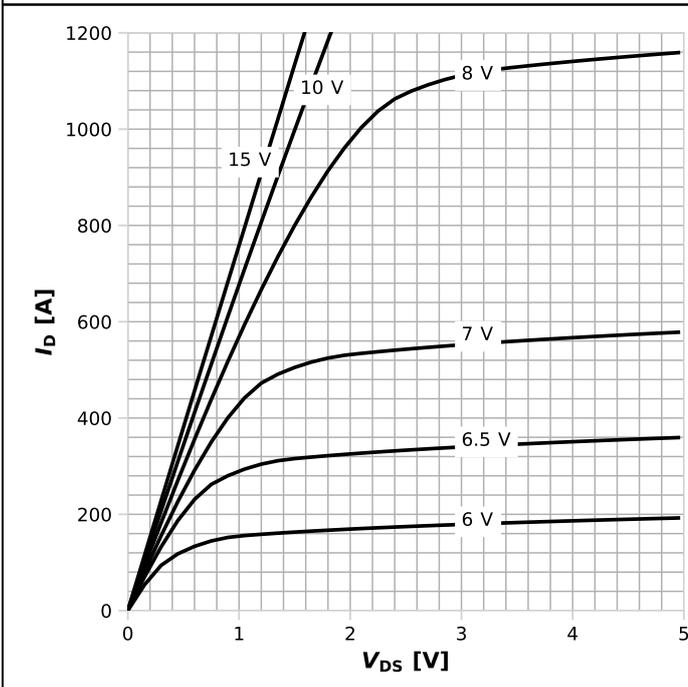
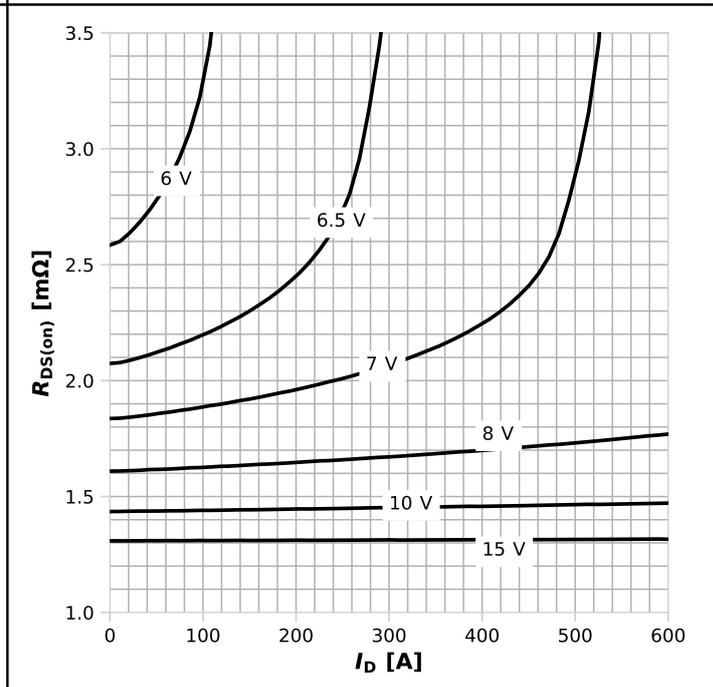


Diagram 5: Typ. output characteristics



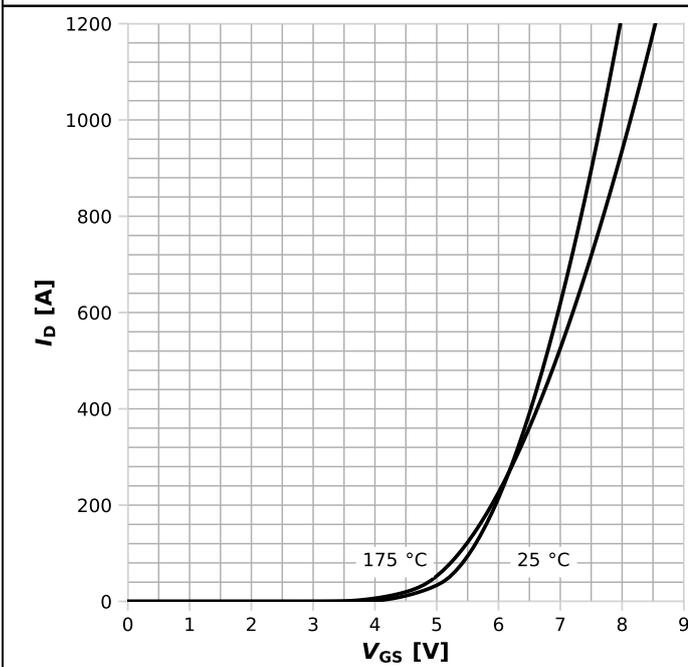
$I_D = f(V_{DS})$, $T_j = 25\text{ °C}$; parameter: V_{GS}

Diagram 6: Typ. drain-source on resistance



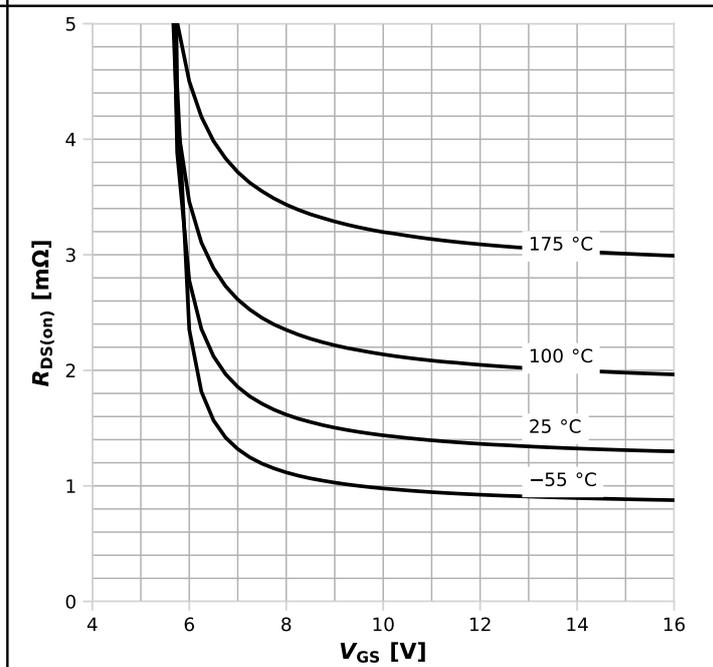
$R_{DS(on)} = f(I_D)$, $T_j = 25\text{ °C}$; parameter: V_{GS}

Diagram 7: Typ. transfer characteristics



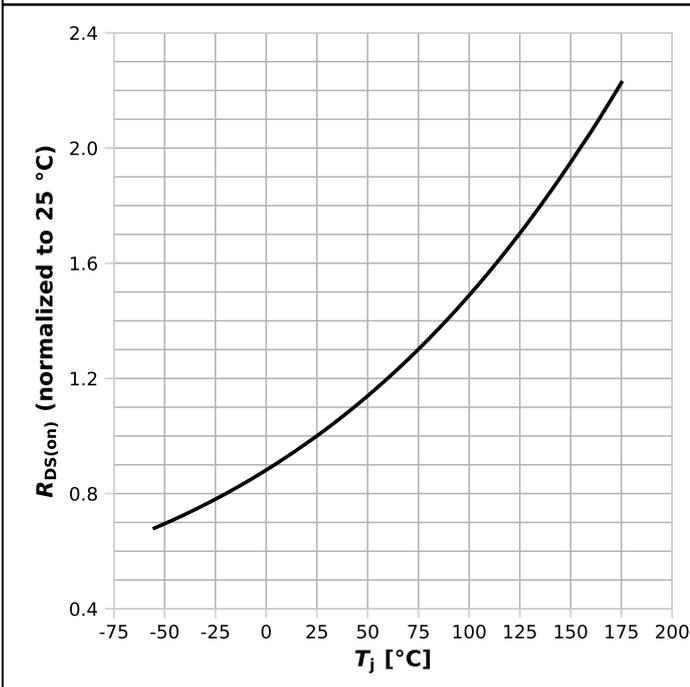
$I_D = f(V_{GS})$, $|V_{DS}| > 2|I_D|R_{DS(on)max}$; parameter: T_j

Diagram 8: Typ. drain-source on resistance



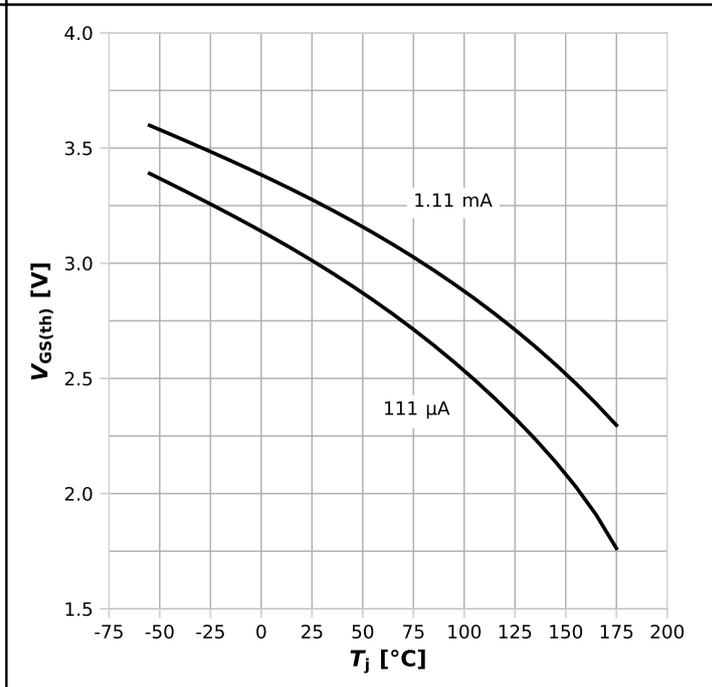
$R_{DS(on)} = f(V_{GS})$, $I_D = 50\text{ A}$; parameter: T_j

Diagram 9: Normalized drain-source on resistance



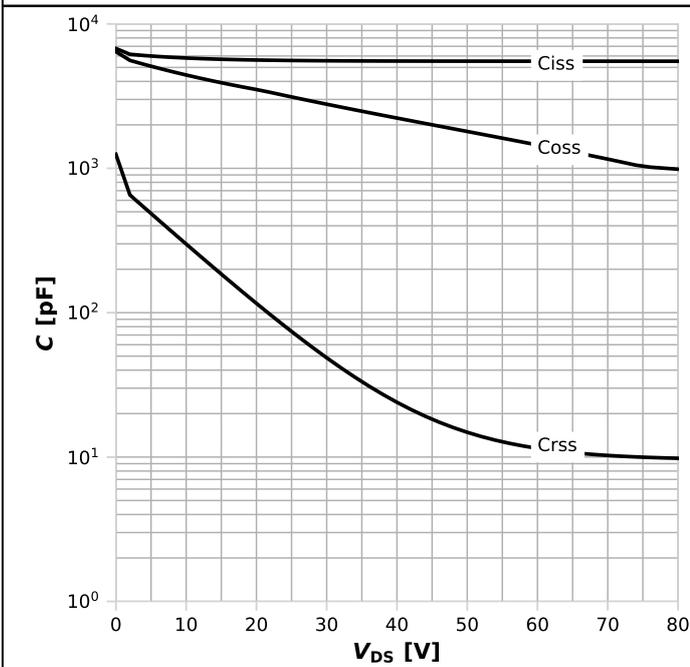
$R_{DS(on)} = f(T_j)$, $I_D = 50$ A, $V_{GS} = 10$ V

Diagram 10: Typ. gate threshold voltage



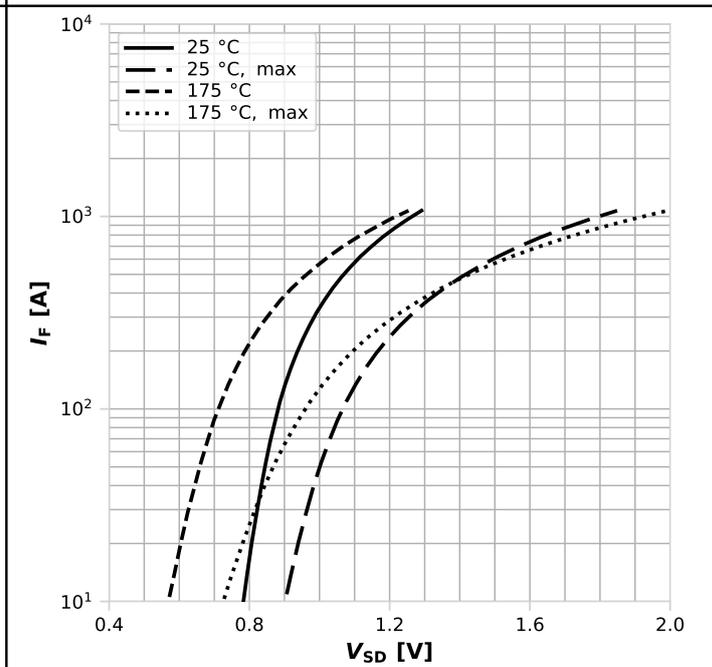
$V_{GS(th)} = f(T_j)$, $V_{GS} = V_{DS}$; parameter: I_D

Diagram 11: Typ. capacitances



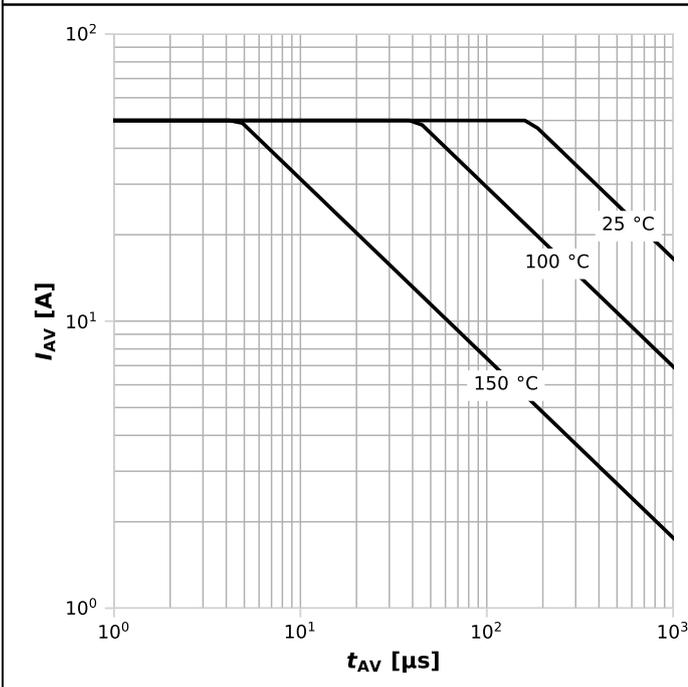
$C = f(V_{DS})$; $V_{GS} = 0$ V; $f = 1$ MHz

Diagram 12: Forward characteristics of reverse diode



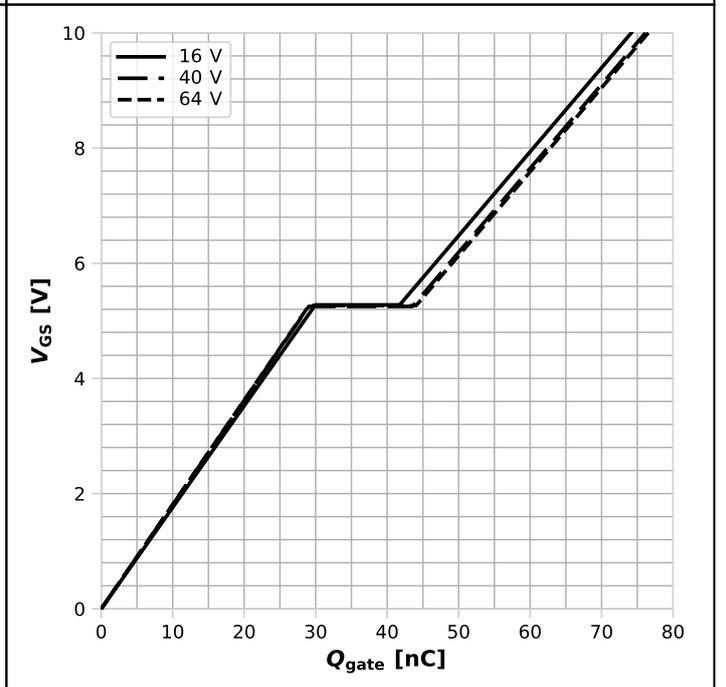
$I_F = f(V_{SD})$; parameter: T_j

Diagram 13: Avalanche characteristics



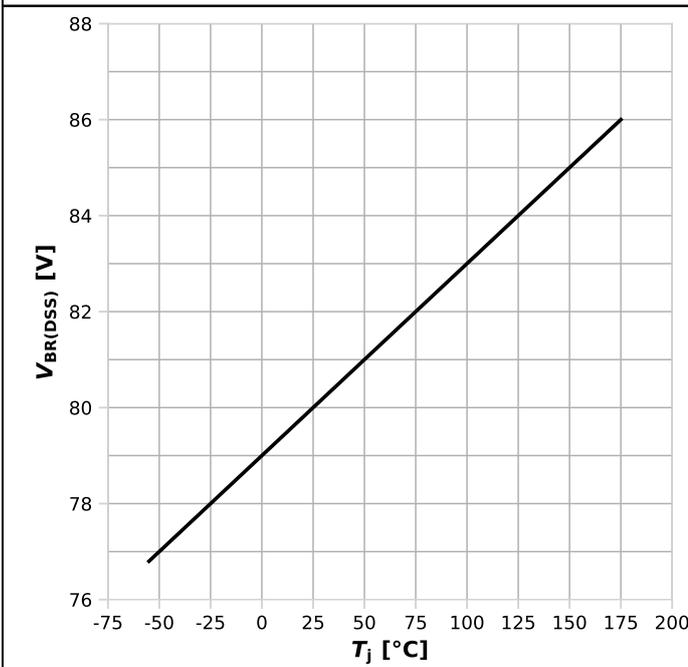
$I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$; parameter: $T_{j,start}$

Diagram 14: Typ. gate charge



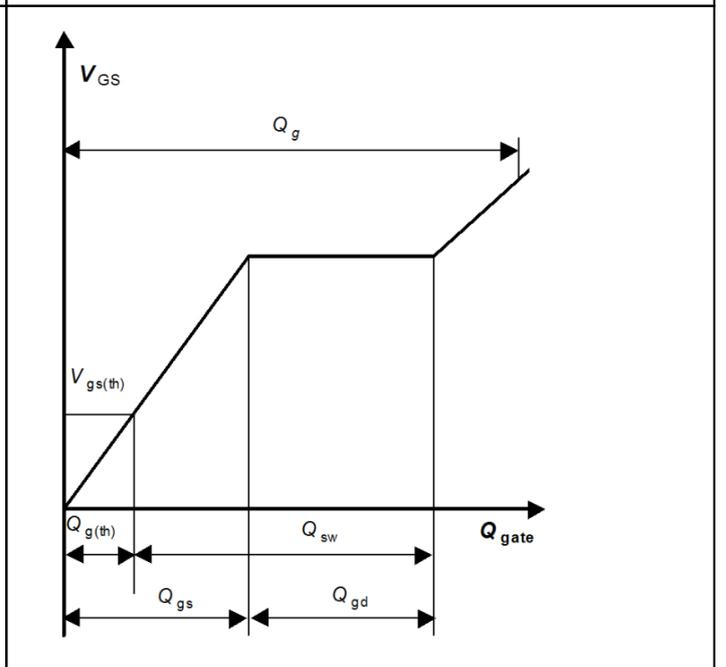
$V_{GS}=f(Q_{gate}), I_D=50 \text{ A pulsed}, T_j=25 \text{ °C}$; parameter: V_{DD}

Diagram 15: Min. drain-source breakdown voltage



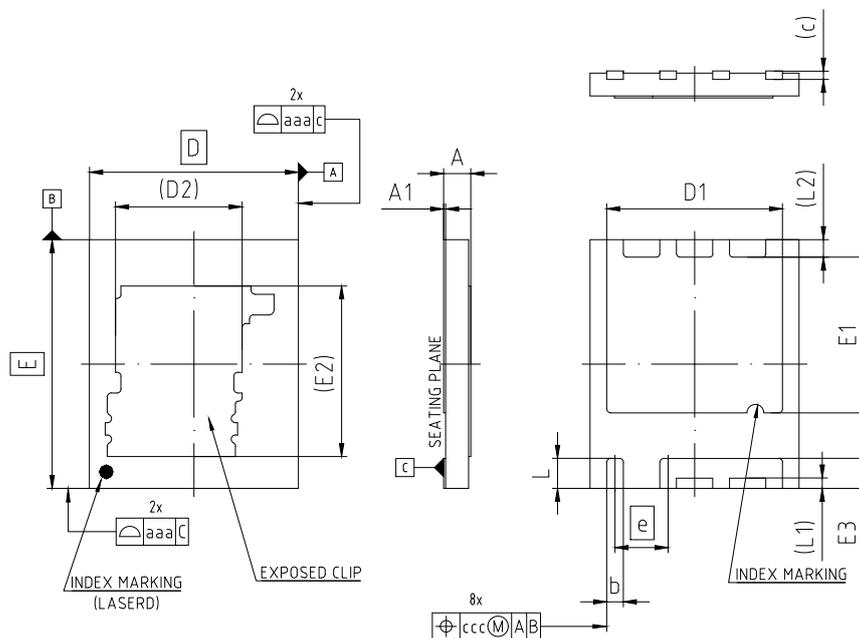
$V_{BR(DSS)}=f(T_j); I_D=1 \text{ mA}$

Gate charge waveforms



-

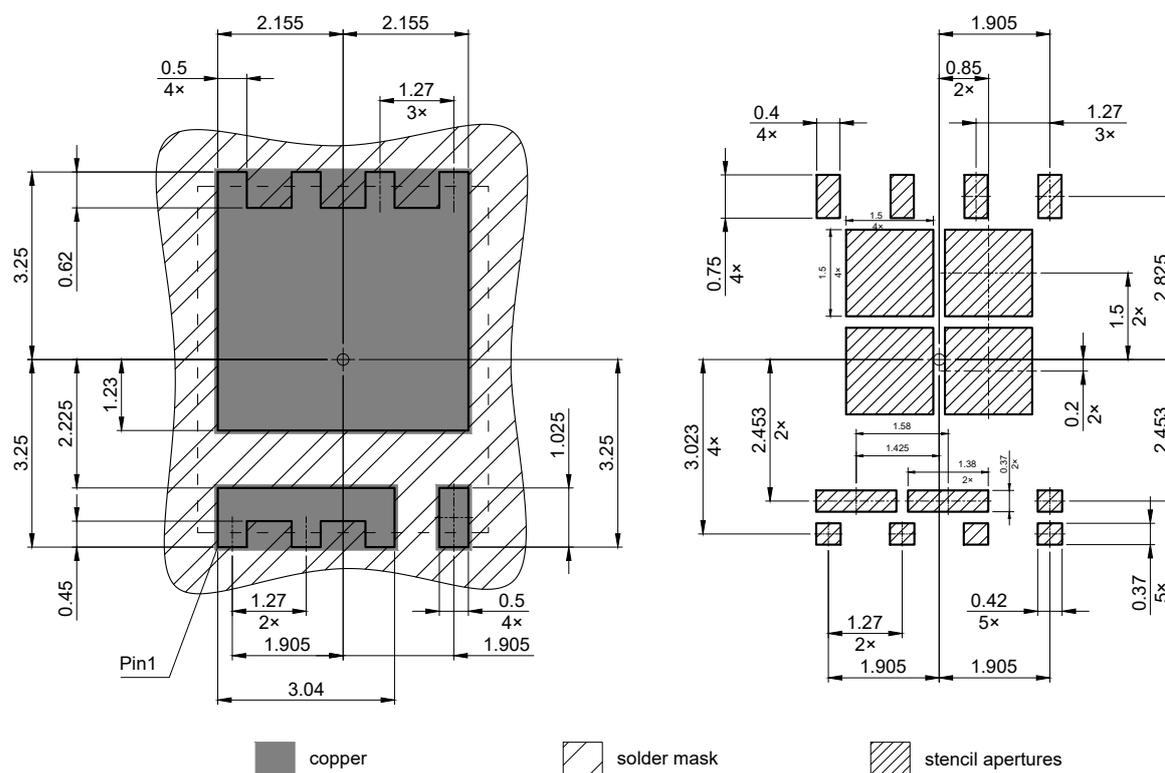
5 Package outlines



| PACKAGE - GROUP NUMBER: PG-WSON-8-U01 | | | | | |
|---------------------------------------|-------------|------|------------|-------------|------|
| DIMENSIONS | MILLIMETERS | | DIMENSIONS | MILLIMETERS | |
| | MIN. | MAX. | | MIN. | MAX. |
| A | 0.55 | 0.75 | e | 1.27 | |
| A1 | 0.00 | 0.05 | L | 0.68 | 0.78 |
| b | 0.35 | 0.45 | L1 | 0.25 | |
| c | 0.20 | | L2 | 0.42 | |
| D | 5.00 | | aaa | 0.05 | |
| D1 | 4.11 | 4.31 | ccc | 0.10 | |
| D2 | 3.03 | | | | |
| E | 6.00 | | | | |
| E1 | 3.66 | 3.86 | | | |
| E2 | 4.11 | | | | |
| E3 | 0.63 | 0.83 | | | |

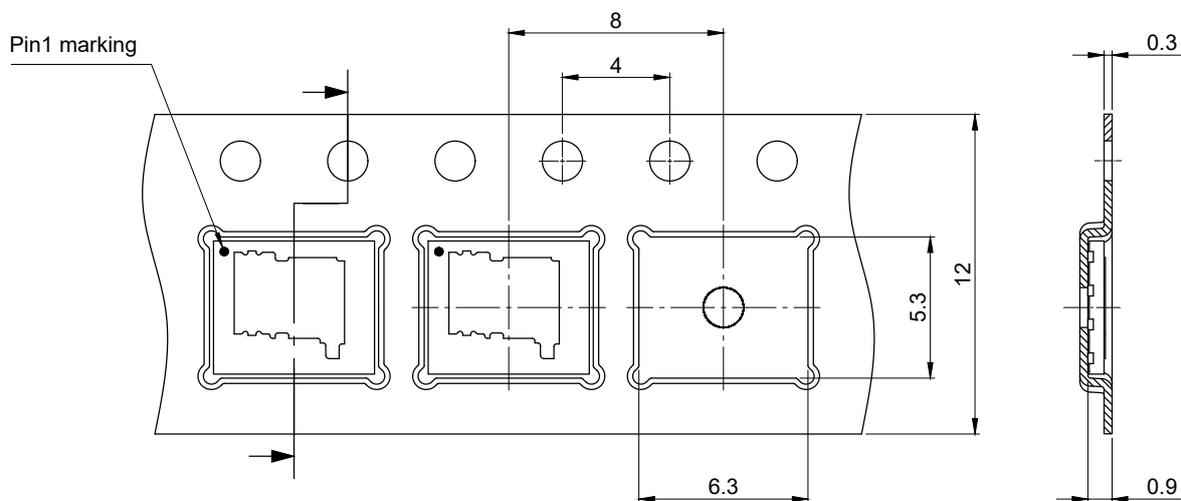
NOTE: DIMENSIONS DO NOT INCLUDE MOLD FLASH, PROTRUSION OR GATE BURRS

Figure 1 Outline PG-WSON-8, dimensions in mm



All dimensions are in units mm

Figure 2 Footprint drawing PG-WSON-8, dimensions in mm



All dimensions are in units mm
The drawing is in compliance with ISO 128-30, Projection Method 1 []

Figure 3 Packaging variant PG-WSON-8, dimensions in mm



Revision history

ISC016N08NM8SC

Revision 2025-12-17, Rev. 1.2

Previous revisions

| Revision | Date | Subjects (major changes since last revision) |
|----------|------------|---|
| 1.0 | 2025-08-21 | Release of final version |
| 1.1 | 2025-10-17 | Updated part marking from "16N08SC" to "016N08SC" |
| 1.2 | 2025-12-17 | Updated RthJC |

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